Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/798,774	SHIRAISHI ET AL.	
Examiner	Art Unit	
Anh T.N. Vo	2861	

SEARCHED					
Class	Subclass	Date	Examiner		
mpdate	Alan	oh vgj	06 AV		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST TEXT SEARCH	9/21/2006	W		
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